Sparch Notes

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Applicant(s)/Patent Under
Reexamination

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Art Unit

Examiner

RYAN J WALTERS 3726

SEARCHED

Class	Subclass	Date	Examiner
29	898.1, 898.02, 898.07, 724	4/30/2010	RJW
184	5.1, 6.22, 64, 7.4	4/30/2010	RJW
384	107, 398, 399, 471	4/30/2010	RJW
141	5, 8	4/30/2010	RJW

SEARCH NOTES

Search Notes	Date	Examiner
Inventor Search	4/30/2010	RJW
EAST	4/30/2010	RJW
Consulted with Essama Omgba for subclass search	4/30/2010	RJW
Conculted with David Bryant on allowable subject matter	10/28/2010	RJW

INTERFERENCE SEARCH

	Class	Subclass	Date	Examiner
	29	898.1, 898.02, 898.07, 724	10/28/2010	RJW
	184	5.1, 7.4	10/28/2010	RJW

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